

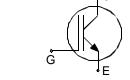
### **IGBT4 Medium Power Chip**

#### **FEATURES:**

- 1200V Trench + Field Stop technology
- low switching losses
- soft turn off
- positive temperature coefficient
- easy paralleling

### This chip is used for:

• medium power modules



### Applications:

medium power drives

Chip Type	V <sub>CE</sub>	<b>I</b> Cn	Die Size	Package		
IGC70T120T6RM	1200V	75A	9.12 x 7.71 mm <sup>2</sup>	sawn on foil		

### MECHANICAL PARAMETER

Raster size	9.12 x 7.71		
Emitter pad size (incl. gate pad)	7.61 x 6.24	mm²	
Gate pad size	1.31 x 0.81	111111	
Area total / active	70.3 / 51.6		
Thickness	120 μ		
Wafer size	150	mm	
Flat position	90	grd	
Max.possible chips per wafer	200		
Passivation frontside	Photoimide		
Pad metal Pad metal	3200 nm AlSiCu		
Backside metal	Ni Ag -system suitable for epoxy and soft solder die bonding		
Die bond	Electrically conductive glue or solder		
Wire bond	Al, <500μm		
Reject ink dot size	∅ 0.65mm ; max 1.2mm		
Recommended storage environment	Store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		

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### **MAXIMUM RATINGS**

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage , T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V	
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А	
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	225	Α	
Gate-Emitter voltage	V <sub>GE</sub>	±20	V	
Operating junction temperature	$T_j$	-40 +175	°C	
Short circuit data <sup>2</sup> ) $V_{CE} = 15V$ , $V_{CC} = 800V$ , $Tvj = 150$ °C	tp	10	μs	
Reverse bias safe operating area <sup>2</sup> (RBSOA)				

<sup>1)</sup> depending on thermal properties of assembly

### STATIC CHARACTERISTICS (tested on wafer ), $T_j$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
- Gramotor	- Cymbei	Conditions	min.	typ.	max.	
Collector-Emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V , $I_{C}$ = 3 m A	1200			
Collector-Emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =75 A	1.6	1.85	2.1	V
Gate-Emitter threshold voltage	V <sub>GE(th)</sub>	I <sub>C</sub> =3mA , V <sub>GE</sub> =V <sub>CE</sub>	5.0	5.8	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			10	μA
Gate-Emitter leakage current	I <sub>GES</sub>	$V_{CE}=0V$ , $V_{GE}=20V$			600	nA
Integrated gate resistor	R <sub>Gint</sub>			10		Ω

### **ELECTRICAL CHARACTERISTICS** (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions	Value			Unit
i didilicici	Cymbol	Conditions	min.	typ.	max.	
Input capacitance	Ciss	V <sub>CE</sub> =25V,		4400		
Output capacitance	Coss	$V_{GE} = 0V$ ,		290		pF
Reverse transfer capacitance	C <sub>rss</sub>	f=1MHz		235		

<sup>&</sup>lt;sup>2)</sup> not subject to production test - verified by design/characterization



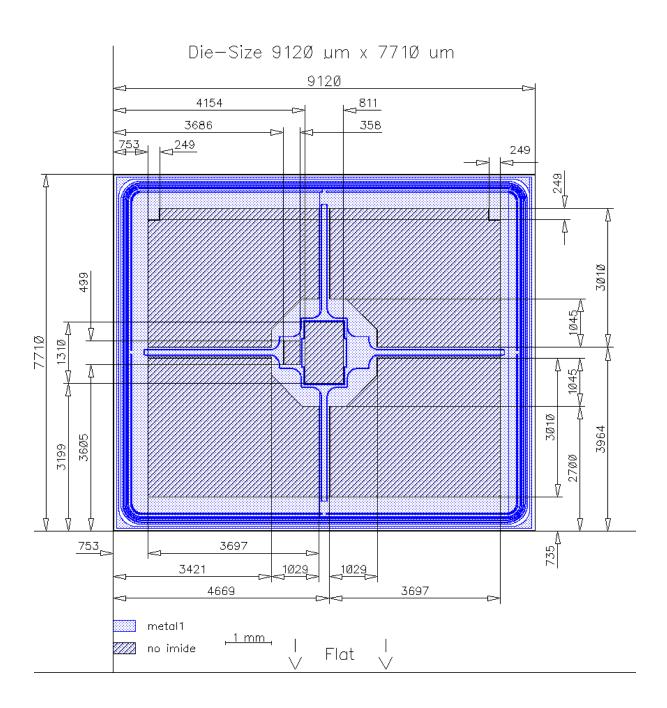
**SWITCHING CHARACTERISTICS** inductive load (not subject to production test - verified by design /characterization)

Parameter	Symbol	Conditions 1)	Value			Unit
Farameter			min.	typ.	max.	Offic
Turn-on delay time	$t_{d(on)}$	$T_{j}=125^{\circ}C$ $V_{CC}=600V$ , $I_{C}=75A$ , $V_{GE}=-15/15V$ , $R_{G}=\Omega$		tbd		
Rise time	t <sub>r</sub>			tbd		ns
Turn-off delay time	$t_{d(off)}$			tbd		"
Fall time	$t_{f}$			tbd		

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



### **CHIP DRAWING**





#### **FURTHER ELECTRICAL CHARACTERISTICS**

This chip data sheet refers to the device data sheet	tbd	

#### DESCRIPTION

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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